
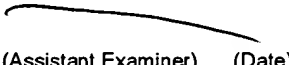
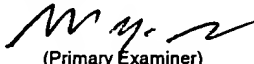
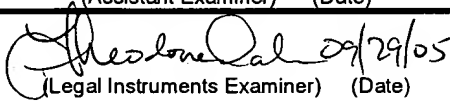


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/774,685	YAMANAKA ET AL.	
	Examiner	Art Unit	
	Wei Y. Zhen	2191	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
717	140								
INTERNATIONAL CLASSIFICATION									
G 0 6 F	9 1 4 5								
			/						
			/						
			/						
			/						

 (Assistant Examiner) (Date)		<b>WEI Y. ZHEN</b> <b>PRIMARY EXAMINER</b>  (Primary Examiner)		Total Claims Allowed: <b>18</b>	
 (Legal Instruments Examiner) (Date)		9/29/05 (Date)		O.G. Print Claim(s) <b>1</b>	O.G. Print Fig. <b>3</b>

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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